

<b>Notice of References Cited</b>	Application/Control No. 10/528,842	Applicant(s)/Patent Under Reexamination SCHECHNER ET AL.	
	Examiner Nikki H. Dees	Art Unit 1794	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0219388 A1	11-2003	Kropf et al.	424/50
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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